

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10597438	OHNO ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chau N Nguyen	2831

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
174	110F	2/27/08	CN
	110R	10/17/08	CN

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text	2/27/08	CN
Text	10/17/08	CN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
see print out		10/24/08	CN

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